Lecture 1: Foundations of Optics

Dutline

- **Electromagnetic Waves**
- **2** Material Properties
- Electromagnetic Waves Across Interfaces
- **•** Fresnel Equations
- **5** Brewster Angle
- **6** Total Internal Reflection

Electromagnetic Waves in Matter

- *Maxwell's equations* ⇒ electromagnetic waves
- **o** optics: interaction of electromagnetic waves with matter as described by *material equations*
- polarization of electromagnetic waves are integral part of optics

Linear Material Equations

$$
\vec{D} = \epsilon \vec{E}
$$

$$
\vec{B} = \mu \vec{H}
$$

$$
\vec{j} = \sigma \vec{E}
$$

Symbols

- *dielectric constant*
- µ *magnetic permeability*
- σ *electrical conductivity*

Isotropic and Anisotropic Media

- isotropic media: ϵ and μ are scalars
- anisotropic media: ϵ and μ are tensors of rank 2
- isotropy of medium broken by
	- anisotropy of material itself (e.g. crystals)
	- external fields (e.g. Kerr effect)

Wave Equation in Matter

- **•** static, homogeneous medium with no net charges: $\rho = 0$
- for most materials: $\mu = 1$
- combine Maxwell, material equations \Rightarrow differential equations for damped (vector) wave

$$
\nabla^2 \vec{E} - \frac{\mu \epsilon}{c^2} \frac{\partial^2 \vec{E}}{\partial t^2} - \frac{4\pi \mu \sigma}{c^2} \frac{\partial \vec{E}}{\partial t} = 0
$$

$$
\nabla^2 \vec{H} - \frac{\mu \epsilon}{c^2} \frac{\partial^2 \vec{H}}{\partial t^2} - \frac{4\pi \mu \sigma}{c^2} \frac{\partial \vec{H}}{\partial t} = 0
$$

- damping controlled by conductivity σ
- \overrightarrow{E} and \overrightarrow{H} are equivalent \Rightarrow sufficient to consider \overrightarrow{E}
- interaction with matter almost always through *E*
- but: at interfaces, boundary conditions for *H*~ are crucial

Plane-Wave Solutions

- P lane Vector Wave ansatz $\vec{E} = \vec{E}_0 e^{i\left(\vec{K}\cdot\vec{x}-\omega t\right)}$
	- \overline{k} spatially and temporally constant *wave vector*
	- \overline{k} normal to surfaces of constant phase
	- $|\vec{k}|$ wave number
		- \vec{x} spatial location
	- ω *angular frequency* (2π× frequency)
	- *t* time
	- \vec{E}_0 (generally complex) vector independent of time and space
- $\vec{E} = \vec{E}_0 e^{-i\left(\vec{K}\cdot\vec{x} \omega t\right)}$
- \bullet damping if \vec{k} is complex
- real electric field vector given by real part of \vec{E}

Complex Index of Refraction

temporal derivatives ⇒ Helmholtz equation

$$
\nabla^2 \vec{E} + \frac{\omega^2 \mu}{c^2} \left(\epsilon + i \frac{4 \pi \sigma}{\omega} \right) \vec{E} = 0
$$

• *dispersion relation* between \vec{k} and ω

$$
\vec{k} \cdot \vec{k} = \frac{\omega^2 \mu}{c^2} \left(\epsilon + i \frac{4\pi \sigma}{\omega} \right)
$$

complex index of refraction

$$
\tilde{n}^2 = \mu \left(\epsilon + i \frac{4\pi \sigma}{\omega} \right), \vec{k} \cdot \vec{k} = \frac{\omega^2}{c^2} \tilde{n}^2
$$

split into real (*n*: *index of refraction*) and imaginary parts (*k*: *extinction coefficient*)

$$
\tilde{n}=n+ik
$$

Transverse Waves

• plane-wave solution must also fulfill Maxwell's equations

$$
\vec{E}_0 \cdot \vec{k} = 0, \ \vec{H}_0 \cdot \vec{k} = 0, \ \vec{H}_0 = \frac{\tilde{n}}{\mu} \frac{\vec{k}}{|\vec{k}|} \times \vec{E}_0
$$

- **•** isotropic media: electric, magnetic field vectors normal to wave vector ⇒ transverse waves
- \vec{E}_0 , \vec{H}_0 , and \vec{k} orthogonal to each other, right-handed vector-triple
- conductive medium \Rightarrow complex $\tilde{n},\,\vec{E}_0$ and \vec{H}_0 out of phase
- \vec{E}_0 and \vec{H}_0 have constant relationship \Rightarrow consider only \vec{E}

Energy Propagation in Isotropic Media

Poynting vector

$$
\vec{S}=\frac{c}{4\pi}\left(\vec{E}\times\vec{H}\right)
$$

- \cdot $|\vec{S}|$: energy through unit area perpendicular to *S* per unit time
- \bullet direction of \vec{S} is direction of energy flow
- **time-averaged Poynting vector given by**

$$
\left\langle \vec{\mathcal{S}}\right\rangle =\frac{c}{8\pi}\text{Re}\left(\vec{E}_{0}\times\vec{H}_{0}^{*}\right)
$$

Re real part of complex expression

- [∗] complex conjugate
- time average

• energy flow parallel to wave vector (in isotropic media)

$$
\left\langle \vec{S}\right\rangle =\frac{c}{8\pi}\frac{\left|\tilde{n}\right|}{\mu}\left|E_{0}\right|^{2}\frac{\vec{k}}{\left|\vec{k}\right|}
$$

Quasi-Monochromatic Light

- **•** monochromatic light: purely theoretical concept
- **•** monochromatic light wave always fully polarized
- real life: light includes range of wavelengths \Rightarrow *quasi-monochromatic light*
- **•** quasi-monochromatic: superposition of mutually incoherent monochromatic light beams whose wavelengths vary in narrow range $\delta\lambda$ around central wavelength λ_0

$$
\frac{\delta\lambda}{\lambda}\ll 1
$$

- measurement of quasi-monochromatic light: integral over measurement time *t^m*
- **•** amplitude, phase (slow) functions of time for given spatial location
- *slow*: variations occur on time scales much longer than the mean period of the wave

Polarization of Quasi-Monochromatic Light

e electric field vector for quasi-monochromatic plane wave is sum of electric field vectors of all monochromatic beams

$$
\vec{E}\left(t\right)=\vec{E}_{0}\left(t\right)e^{i\left(\vec{k}\cdot\vec{x}-\omega t\right)}
$$

- **•** can write this way because $\delta \lambda \ll \lambda_0$
- measured intensity of quasi-monochromatic beam

$$
\left\langle \vec{E}_x \vec{E}_x^* \right\rangle + \left\langle \vec{E}_y \vec{E}_y^* \right\rangle = \lim_{t_m \to \infty} \frac{1}{t_m} \int_{-t_m/2}^{t_m/2} \vec{E}_x(t) \vec{E}_x^*(t) + \vec{E}_y(t) \vec{E}_y^*(t) dt
$$

- $\langle \cdots \rangle$: averaging over measurement time t_m
- **•** measured intensity independent of time
- **o** quasi-monochromatic: frequency-dependent material properties (e.g. index of refraction) are constant within $\Delta\lambda$

Polychromatic Light or White Light

- wavelength range comparable wavelength ($\frac{\delta \lambda}{\lambda} \sim$ 1)
- incoherent sum of quasi-monochromatic beams that have large variations in wavelength
- **•** cannot write electric field vector in a plane-wave form
- **•** must take into account frequency-dependent material characteristics
- intensity of polychromatic light is given by sum of intensities of constituting quasi-monochromatic beams

Material Properties

Index of Refraction

• complex index of refraction

$$
\tilde{n}^2 = \mu \left(\epsilon + i \frac{4\pi \sigma}{\omega} \right), \vec{k} \cdot \vec{k} = \frac{\omega^2}{c^2} \tilde{n}^2
$$

- no electrical conductivity \Rightarrow real index of refraction
- **o** dielectric materials: real index of refraction
- **•** conducting materials (metal): complex index of refraction
- index of refraction depends on wavelength (dispersion)
- index of refraction depends on temperature
- index of refraction roughly proportional to density

Glass Dispersion

Christoph U. Keller, Utrecht University, C.U.Keller@uu.nl Lecture 1: Foundations of Optics 13

Wavelength Dependence of Index of Refraction

- tabulated by glass manufacturer
- various approximations to express wavelength dependence with a few parameters
- **•** typically index increases with decreasing wavelength
- **Abbé number:**

$$
\nu_d = \frac{n_d - 1}{n_F - n_C}
$$

- **•** n_d : index of refraction at Fraunhofer d line (587.6 nm)
- **•** n_F : index of refraction at Fraunhofer F line (486.1 nm)
- *nC*: index of refraction at Fraunhofer C line (656.3 nm)
- **•** low dispersion materials have high values of ν_d
- Abbe diagram: ν*^d* vs *n^d*

Glasses

Christoph U. Keller, Utrecht University, C.U.Keller@uu.nl Lecture 1: Foundations of Optics 15

Glass Ingredients

http://glassproperties.com/abbe_number

Internal Transmission

Typical Transmission of LITHOSIL® (10 mm path length)

Transmission including Fresnel reflection losses/internal Transmission without Fresnel reflection

- **o** internal transmission per cm
- typically strong absorption in the blue and UV
- almost all glass absorbs above 2 μ m

Metal Reflectivity

<http://commons.wikimedia.org/wiki/File:Image-Metal-reflectance.png>

Electromagnetic Waves Across Interfaces

Introduction

- classical optics due to interfaces between 2 different media
- **•** from Maxwell's equations in integral form at interface from medium 1 to medium 2

$$
\left(\vec{D}_2 - \vec{D}_1\right) \cdot \vec{n} = 4\pi\Sigma
$$

$$
\left(\vec{B}_2 - \vec{B}_1\right) \cdot \vec{n} = 0
$$

$$
\left(\vec{E}_2 - \vec{E}_1\right) \times \vec{n} = 0
$$

$$
\left(\vec{H}_2 - \vec{H}_1\right) \times \vec{n} = -\frac{4\pi}{c}\vec{K}
$$

- \vec{n} normal on interface, points from medium 1 to medium 2
- Σ surface charge density on interface
- \vec{K} surface current density on interface

Fields at Interfaces

- \sum = 0 in general, \vec{K} = 0 for dielectrics
- *complex* index of refraction includes effects of currents $\Rightarrow \vec{K} = 0$ \bullet
- **•** requirements at interface between media 1 and 2

$$
\begin{aligned}\n\left(\vec{D}_2 - \vec{D}_1\right) \cdot \vec{n} &= 0 \\
\left(\vec{B}_2 - \vec{B}_1\right) \cdot \vec{n} &= 0 \\
\left(\vec{E}_2 - \vec{E}_1\right) \times \vec{n} &= 0 \\
\left(\vec{H}_2 - \vec{H}_1\right) \times \vec{n} &= 0\n\end{aligned}
$$

- normal components of \vec{D} and \vec{B} are continuous across interface
- tangential components of \vec{E} and \vec{H} are continuous across interface

Plane of Incidence

- plane wave onto interface
- incident (*ⁱ*), reflected (*^r*), and transmitted (*^t*) waves

$$
\vec{E}^{i,r,t} = \vec{E}_0^{i,r,t} e^{i(\vec{K}^{i,r,t}, \vec{x}-\omega t)} \n\vec{H}^{i,r,t} = \frac{c}{\mu \omega} \vec{K}^{i,r,t} \times \vec{E}^{i,r,t}
$$

- interface normal $\vec{n} \parallel z$ -axis
- spatial, temporal behavior at interface the same for all 3 waves

$$
(\vec{k}^{l}\cdot\vec{x})_{z=0}=(\vec{k}^{r}\cdot\vec{x})_{z=0}=(\vec{k}^{t}\cdot\vec{x})_{z=0}
$$

interface

• valid for all \vec{x} in interface \Rightarrow all 3 wave vectors in one plane, *plane of incidence*

plane of incidence

Snell's Law

• spatial, temporal behavior the same for all three waves

$$
(\vec{k}^i \cdot \vec{x})_{z=0} = (\vec{k}^r \cdot \vec{x})_{z=0} = (\vec{k}^t \cdot \vec{x})_{z=0}
$$

$$
\bullet \left| \vec{k} \right| = \frac{\omega}{c} \tilde{n}
$$

- ω , \boldsymbol{c} the same for all 3 waves
- *Snell's law*

$$
\tilde{n}_1 \sin \theta_i = \tilde{n}_1 \sin \theta_r = \tilde{n}_2 \sin \theta_t
$$

Monochromatic Wave at Interface

 \bullet

$$
\vec{H}_0^{i,r,t} = \frac{c}{\omega\mu} \vec{K}^{i,r,t} \times \vec{E}_0^{i,r,t}, \quad \vec{B}_0^{i,r,t} = \frac{c}{\omega} \vec{K}^{i,r,t} \times \vec{E}_0^{i,r,t}
$$

• boundary conditions for monochromatic plane wave:

$$
\begin{aligned}\n\left(\tilde{\eta}_{1}^{2}\vec{E}_{0}^{i}+\tilde{\eta}_{1}^{2}\vec{E}_{0}^{r}-\tilde{\eta}_{2}^{2}\vec{E}_{0}^{t}\right)\cdot\vec{n}=0\\
\left(\vec{k}^{i}\times\vec{E}_{0}^{i}+\vec{k}^{r}\times\vec{E}_{0}^{r}-\vec{k}^{t}\times\vec{E}_{0}^{t}\right)\cdot\vec{n}=0\\
\left(\vec{E}_{0}^{i}+\vec{E}_{0}^{r}-\vec{E}_{0}^{t}\right)\times\vec{n}=0\\
\left(\frac{1}{\mu_{1}}\vec{k}^{i}\times\vec{E}_{0}^{i}+\frac{1}{\mu_{1}}\vec{k}^{r}\times\vec{E}_{0}^{r}-\frac{1}{\mu_{2}}\vec{k}^{t}\times\vec{E}_{0}^{t}\right)\times\vec{n}=0\n\end{aligned}
$$

• 4 equations are not independent

• only need to consider last two equations (tangential components of \vec{E}_0 and \vec{H}_0 are continuous)

Two Special Cases

- ¹ electric field **p**arallel to plane of incidence ⇒ magnetic field is transverse to plane of incidence (TM)
- ² electric field particular (German: **s**enkrecht) or transverse to plane of incidence (TE)
	- **•** general solution as (coherent) superposition of two cases
	- choose direction of magnetic field vector such that Poynting vector parallel, same direction as corresponding wave vector

Electric Field Perpendicular to Plane of Incidence

$$
\bullet \ \theta_r = \theta_i
$$

• ratios of reflected and transmitted to incident wave amplitudes

$$
r_s = \frac{E_0^r}{E_0^i} = \frac{\tilde{n}_1 \cos \theta_i - \frac{\mu_1}{\mu_2} \tilde{n}_2 \cos \theta_t}{\tilde{n}_1 \cos \theta_i + \frac{\mu_1}{\mu_2} \tilde{n}_2 \cos \theta_t}
$$

$$
t_s = \frac{E_0^t}{E_0^i} = \frac{2\tilde{n}_1 \cos \theta_i}{\tilde{n}_1 \cos \theta_i + \frac{\mu_1}{\mu_2} \tilde{n}_2 \cos \theta_t}
$$

Electric Field in Plane of Incidence

ratios of reflected and transmitted to incident wave amplitudes

$$
\begin{aligned} r_{\textsf{p}} &= \frac{E_0^{\textsf{r}}}{E_0^{\textsf{i}}} = \frac{\tilde{n}_2 \cos \theta_i \frac{\mu_1}{\mu_2} - \tilde{n}_1 \cos \theta_t}{\tilde{n}_2 \cos \theta_i \frac{\mu_1}{\mu_2} + \tilde{n}_1 \cos \theta_t} \\ t_{\textsf{p}} &= \frac{E_0^{\textsf{t}}}{E_0^{\textsf{i}}} = \frac{2 \tilde{n}_1 \cos \theta_i}{\tilde{n}_2 \cos \theta_i \frac{\mu_1}{\mu_2} + \tilde{n}_1 \cos \theta_t} \end{aligned}
$$

Summary of Fresnel Equations

- eliminate θ_t using Snell's law $\tilde{n}_2 \cos \theta_t = \sqrt{\tilde{n}_2^2 \tilde{n}_1^2 \sin^2 \theta_t}$
- for most materials $\mu_1/\mu_2 \approx 1$
- \bullet electric field amplitude transmission $t_{s,p}$, reflection $r_{s,p}$

$$
t_{s} = \frac{2\tilde{n}_{1}\cos\theta_{i}}{\tilde{n}_{1}\cos\theta_{i} + \sqrt{\tilde{n}_{2}^{2} - \tilde{n}_{1}^{2}\sin^{2}\theta_{i}}}
$$
\n
$$
t_{p} = \frac{2\tilde{n}_{1}\tilde{n}_{2}\cos\theta_{i}}{\tilde{n}_{2}^{2}\cos\theta_{i} + \tilde{n}_{1}\sqrt{\tilde{n}_{2}^{2} - \tilde{n}_{1}^{2}\sin^{2}\theta_{i}}}
$$
\n
$$
r_{s} = \frac{\tilde{n}_{1}\cos\theta_{i} - \sqrt{\tilde{n}_{2}^{2} - \tilde{n}_{1}^{2}\sin^{2}\theta_{i}}}{\tilde{n}_{1}\cos\theta_{i} + \sqrt{\tilde{n}_{2}^{2} - \tilde{n}_{1}^{2}\sin^{2}\theta_{i}}}
$$
\n
$$
r_{p} = \frac{\tilde{n}_{2}^{2}\cos\theta_{i} - \tilde{n}_{1}\sqrt{\tilde{n}_{2}^{2} - \tilde{n}_{1}^{2}\sin^{2}\theta_{i}}}{\tilde{n}_{2}^{2}\cos\theta_{i} + \tilde{n}_{1}\sqrt{\tilde{n}_{2}^{2} - \tilde{n}_{1}^{2}\sin^{2}\theta_{i}}}
$$

Consequences of Fresnel Equations

- complex index of refraction $\Rightarrow t_s$, t_p , r_s , r_p (generally) complex
- real indices \Rightarrow argument of square root can still be negative \Rightarrow complex t_s , t_p , r_s , r_p
- **•** real indices, arguments of square roots positive (e.g. dielectric without total internal reflection)
	- therefore $t_{s,p} \geq 0$, real \Rightarrow incident and transmitted waves will have same phase
	- therefore $r_{s,p}$ real, but become negative when $n_2 > n_1 \Rightarrow$ negative ratios indicate phase change by 180◦ on reflection by medium with larger index of refraction

Other Form of Fresnel Equations

• using trigonometric identities

$$
t_s = \frac{2 \sin \theta_t \cos \theta_i}{\sin(\theta_i + \theta_t)}
$$
\n
$$
t_p = \frac{2 \sin \theta_t \cos \theta_i}{\sin(\theta_i + \theta_t) \cos(\theta_i - \theta_t)}
$$
\n
$$
r_s = \frac{\sin(\theta_i - \theta_t)}{\sin(\theta_i + \theta_t)}
$$
\n
$$
r_p = \frac{\tan(\theta_i - \theta_t)}{\tan(\theta_i + \theta_t)}
$$

- **•** refractive indices "hidden" in angle of transmitted wave, θ_t
- **•** can always rework Fresnel equations such that only ratio of refractive indices appears
- $\bullet \Rightarrow$ Fresnel equations do not depend on absolute values of indices
- can arbitrarily set index of air to 1; then only use indices of media measured relative to air

Relative Amplitudes for Arbitrary Polarization

- electric field vector of incident wave \vec{E}_0^i , length E_0^i , at angle α to plane of incidence
- decompose into 2 components: parallel and perpendicular to interface

$$
E^i_{0,p}=E^i_0\cos\alpha\,,~~E^i_{0,s}=E^i_0\sin\alpha
$$

use Fresnel equations to obtain corresponding (complex) amplitudes of reflected and transmitted waves

$$
E_{0,p}^{r,t} = (r_p, t_p) E_0^i \cos \alpha, \ \ E_{0,s}^{r,t} = (r_s, t_s) E_0^i \sin \alpha
$$

Reflectivity

- **•** Fresnel equations apply to electric field amplitude
- **•** need to determine equations for intensity of waves
- time-averaged Poynting vector $\left<\vec{\mathcal{S}}\right> = \frac{c}{8\pi}$ $|\tilde{n}|$ $\frac{\tilde{n}|}{\mu}\left|\boldsymbol{E_0}\right|^2\frac{\bar{k}}{|\bar{k}|}$ $|\vec{k}|$
- absolute value of complex index of refraction enters
- **•** energy along wave vector and not along interface normal
- \bullet each wave propagates in different direction \Rightarrow consider energy of each wave passing through unit surface area on interface
- does not matter for reflected wave ⇒ ratio of reflected and incident intensities is independent of these two effects
- relative intensity of reflected wave (*reflectivity*)

$$
R = \frac{\left|E_0'\right|^2}{\left|E_0'\right|^2}
$$

Transmissivity

- **•** transmitted intensity: multiplying amplitude squared ratios with
	- ratios of indices of refraction
	- projected area on interface
- relative intensity of transmitted wave (*transmissivity*)

$$
T = \frac{\left|\tilde{n}_2\right|\cos\theta_t\left|E_0^t\right|^2}{\left|\tilde{n}_1\right|\cos\theta_t\left|E_0^i\right|^2}
$$

arbitrarily polarized light with \vec{E}_0^i at angle α to plane of incidence

$$
R = |r_p|^2 \cos^2 \alpha + |r_s|^2 \sin^2 \alpha
$$

$$
T = \frac{|\tilde{n}_2| \cos \theta_t}{|\tilde{n}_1| \cos \theta_t} (|t_p|^2 \cos^2 \alpha + |t_s|^2 \sin^2 \alpha)
$$

 \bullet $R + T = 1$ for dielectrics, not for conducting, absorbing materials

Brewster Angle

0

•
$$
r_p = \frac{\tan(\theta_i - \theta_t)}{\tan(\theta_i + \theta_t)} = 0
$$
 when $\theta_i + \theta_t = \frac{\pi}{2}$

- corresponds to *Brewster angle* of incidence of tan $\theta_B = \frac{n_2}{n_1}$ *n*1
- occurs when reflected wave is perpendicular to transmitted wave
- reflected light is completely s-polarized
- **•** transmitted light is moderately polarized

Total Internal Reflection (TIR)

• Snell's law:
$$
\sin \theta_t = \frac{n_1}{n_2} \sin \theta_i
$$

- wave from high-index medium into lower index medium (e.g. glass to air): $n_1/n_2 > 1$
- right-hand side > 1 for sin $\theta_i > \frac{n_2}{n_1}$ *n*1
- all light is reflected in high-index medium ⇒ *total internal reflection*
- \bullet transmitted wave has complex phase angle \Rightarrow damped wave along interface

Phase Change on Total Internal Reflection (TIR)

- TIR induces phase change that depends on polarization
- **o** complex ratios:
	- $r_{\textit{s,p}} = |r_{\textit{s,p}}|e^{i\delta_{\textit{s,p}}}$
- **o** phase change $\delta = \delta_s \delta_p$

$$
\tan\frac{\delta}{2}=\frac{\cos\theta_i\sqrt{\sin^2\theta_i-\left(\frac{n_2}{n_1}\right)^2}}{\sin^2\theta_i}
$$

- **•** relation valid between critical angle and grazing incidence
- for critical angle and grazing incidence, phase difference is zero

